



**PATENT APPLICATION**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

James M. KRONROD

Art Unit: 2858

Application No.: 10/805,232

Examiner: Amy He

Filed: March 22, 2004

Attorney Dkt. No.: 58268.00369

For: SYSTEM AND METHOD FOR MEASURING THE THICKNESS OR  
TEMPERATURE OF A CIRCUIT IN A PRINTED CIRCUIT

**RESPONSE UNDER 37 CFR § 1.111**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

August 18, 2005

Sir:

In response to the Office Action dated May 26, 2005, please amend the above-identified application as set forth below.

**Amendments to the specification are submitted on page 2.**

**Amendments to the claims are submitted on page 3.**

**Remarks are submitted on page 22.**